

PC1231xNSZ Series

DIP 4pin Reinforced Insulation Type, High CMR, Low Input Current Photocoupler



■ Description

PC1231xNSZ Series contains an IRED optically coupled to a phototransistor.

It is packaged in a 4-pin DIP, available in wide-lead spacing option and SMT gullwing lead-form option. Input-output isolation voltage(rms) is 5.0kV. CTR is 50% to 400% at input current of 0.5mA.

■ Features

- 1. 4pin DIP package
- 2. Double transfer mold package (Ideal for Flow Soldering)
- 3. Low input current type (I_F=0.5mA)
- High resistance to noise due to high common rejection voltage (CMR: MIN. 10kV/μs)
- 5. Reinforced insulation type (Isolation distance : MIN. 0.4mm)
- 6. Long creepage distance type (wide lead-form type only: MIN. 8mm)
- 7. High isolation voltage between input and output (V_{iso(rms)}: 5.0kV)

■ Agency approvals/Compliance

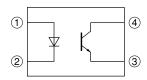
- 1. Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. **PC1231**)
- 2. Approved by BSI, BS-EN60065, file No. 7087, BS-EN60950, file No. 7409, (as model No. **PC1231**)
- 3. Package resin: UL flammability grade (94V-0)
- Approved by SEMCO, EN60065, EN60950, file No. 9933036 (as model No. PC1231)
- 5. Approved by DEMCO, EN60065, EN60950, file No. 99-03814 (as model No. **PC1231**)
- Approved by NEMKO, EN60065, EN60950, file No. P99102251 (as model No. PC1231)
- Approved by FIMKO, EN60065, EN60950, file No. 13986 (as model No. PC1231)
- 8. Recognized by CSA file No. CA095323 (as model No. **PC1231**)
- Approved by VDE, VDE0884 (as an option) file No. 83601, No. 134349 or No. 40005304(as model No. PC1231)

■ Applications

- Primary to secondary isolation in switch mode power supply
- 2. Noise suppression in switching circuit
- Signal transmission between circuits of different potentials and impedances
- 4. Over voltage detection



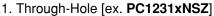
■ Internal Connection Diagram

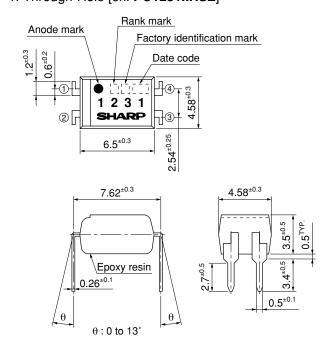


- 1 Anode
- ② Cathode
- 3 Emitter
- 4 Collector

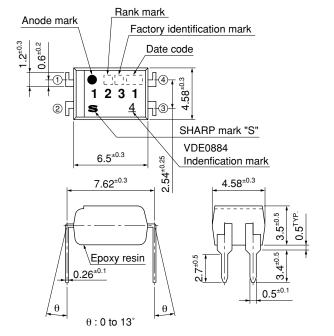
■ Outline Dimensions

(Unit: mm)

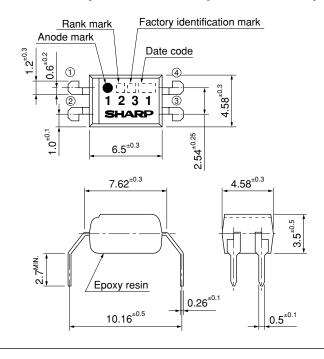




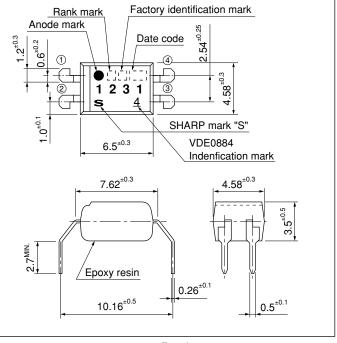
2. Through-Hole [ex. PC1231xYSZ]



3. Wide Through-Hole Lead-Form [ex. PC1231xNFZ]



4. Wide Through-Hole Lead-Form [ex. PC1231xYFZ]

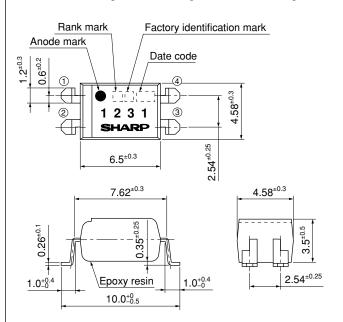


Product mass: approx. 0.18g

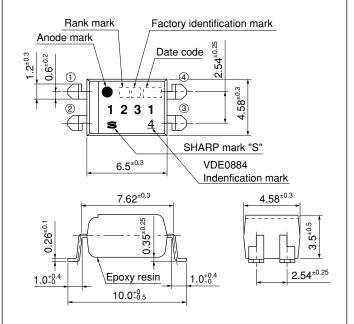


(Unit: mm)

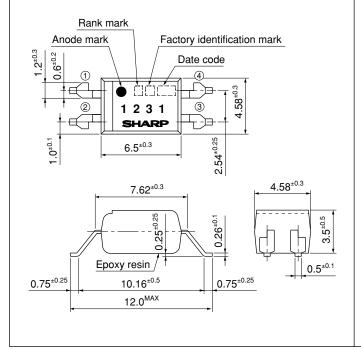
5. SMT Gullwing Lead-Form [ex. PC1231xNIP]



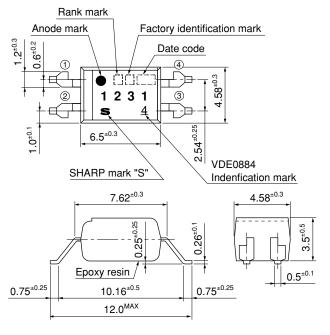
6. SMT Gullwing Lead-Form [ex. PC1231xYIP]



7. Wide SMT Gullwing Lead-Form [ex. PC1231xNUP]



8. Wide SMT Gullwing Lead-Form [ex. PC1231xYUP]



Product mass: approx. 0.18g



Date code (2 digit)

	1st o	digit		2nd	digit		
	Year of p	roduction		Month of j	2nd digit Month of production Month Mark January 1 February 2 March 3 April 4		
A.D.	Mark	A.D	Mark	Month	Mark		
1990	A	2002	P	January	1		
1991	В	2003	R	February	2		
1992	С	2004	S	March	3		
1993	D	2005	T	April	4		
1994	Е	2006	U	May	5		
1995	F	2007	V	June	6		
1996	Н	2008	W	July	7		
1997	J	2009	X	August	8		
1998	K	2010	A	September	9		
1999	L	2011	В	October	0		
2000	M	2012	С	November	N		
2001	N	:	i	December	D		

repeats in a 20 year cycle

Factory identification mark

Factory identification Mark	Country of origin	
no mark		
	Japan	
	Indonesia	
$\overline{}$	Philippines	
_	China	

^{*} This factory marking is for identification purpose only.

Please contact the local SHARP sales representative to see the actual status of the production.

Rank mark

Refer to the Model Line-up table



	■ Absolute Maximum Ratings $(T_a=25^{\circ}C)$							
	Parameter	Symbol	Rating	Unit				
	Forward current	I_{F}	10	mA				
Input	*1 Peak forward current	I_{FM}	200	mA				
In	Reverse voltage	V_R	6	V				
	Power dissipation	P	15	mW				
	Collector-emitter voltage	V_{CEO}	70	V				
Output	Emitter-collector voltage	V _{ECO}	6	V				
Out	Collector current	I_{C}	50	mA				
	Collector power dissipation	P_{C}	150	mW				
-	Total power dissipation	P_{tot}	170	mW				
*2]	Isolation voltage	V _{iso (rms)}	5.0	kV				
Operating temperature		T_{opr}	-30 to +100	°C				
Storage temperature		T_{stg}	-55 to +125	°C				
*3 (Soldering temperature	T_{sol}	260	°C				

^{*1} Pulse width≤100μs, Duty ratio : 0.001 *2 40 to 60%RH, AC for 1 minute, f=60Hz *3 For 10s

■ Electro-optical Characteristics

 $(T_a=25^{\circ}C)$

	Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
	Forward voltage		V_F	$I_F=10mA$	_	1.2	1.4	V
Input	Reverse curre	Reverse current		$V_R=4V$	_	-	10	μΑ
	Terminal capacitance		C_t	V=0, f=1kHz	_	30	250	pF
	Collector dark	current	I_{CEO}	V_{CE} =50V, I_F =0	_	_	100	nA
Output	Collector-emitter brea	kdown voltage	BV_{CEO}	$I_{C}=0.1 \text{ mA}, I_{F}=0$	70	_	_	V
	Emitter-collector breakdown voltage		BV_{ECO}	$I_{E}=10\mu A, I_{F}=0$	6	_	_	V
	Collector curr	ent	I_{C}	$I_F=0.5$ mA, $V_{CE}=5$ V		_	2.0	mA
	Collector-emitter saturation voltage		V _{CE (sat)}	$I_F=10mA$, $I_C=1mA$	-	-	0.2	V
	Isolation resistance		R_{ISO}	DC500V, 40 to 60%RH	5×10 ¹⁰	1×10 ¹¹	_	Ω
Transfer	Floating capac	citance	$C_{\rm f}$	V=0, $f=1MHz$	-	0.6	1.0	pF
charac- teristics	Desmanas tima	Rise time	t _r	V 2V I 2m A B 1000	_	4	18	μs
teristics	Response time	Fall time	$t_{\rm f}$	V_{CE} =2V, I_{C} =2mA, R_{L} =100 Ω	_	3	18	μs
	Common mode rejection voltage		CMR	$\begin{aligned} &V_{\text{CM}}\text{=}1.5\text{kV}(\text{peak}), I_{\text{F}}\text{=}0\\ &R_{\text{L}}\text{=}470\Omega, V_{\text{CC}}\text{=}9\text{V}, V_{\text{np}}\text{=}100\text{mV} \end{aligned}$	10	_	_	kV/μs



■ Model Line-up

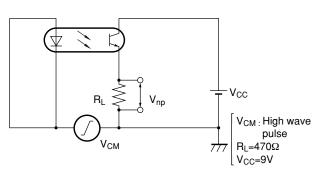
Lead Form	Trougl	h-Hole	Wide Tro	ugh-Hole	SMT G	ullwing	Wide SM7	Gullwing Gullwing		T [A]	
Doolsoon		Sleeve				Taping			Rank mark	$I_{\rm C}$ [mA] $(I_{\rm E}=0.5$ mA, $V_{\rm CE}=5$ V, $T_{\rm a}=25$ °C)	
Package		100pcs	s/sleeve			2000p	cs/reel			(IF-0.3IIIA, VCE-3V, Ia-23C)	
VDE0884	_	Approved	-	Approved	-	Approved	_	Approved	-		
									with or without	0.25 to 2.0	
Model No.	PC12311NSZ	PC12311YSZ	PC12311NFZ	PC12311YFZ	PC12311NIP	PC12311YIP	PC12311NUP	PC12311YUP	A	0.5 to 1.25	

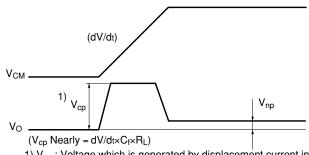
Please contact a local SHARP sales representative to inquire about production status and Lead-Free options.

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Fig.1 Test Circuit for Common Mode Rejection Voltage





1) V_{cp} : Voltage which is generated by displacement current in floating capacitance between primary and secondary side.

Fig.2 Forward Current vs. Ambient Temperature

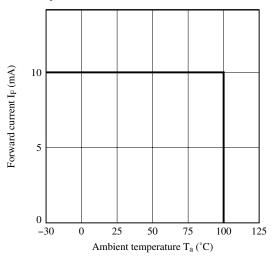


Fig.3 Diode Power Dissipation vs. Ambient Temperature

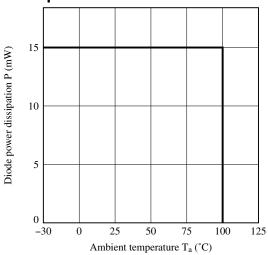


Fig.4 Collector Power Dissipation vs. Ambient Temperature

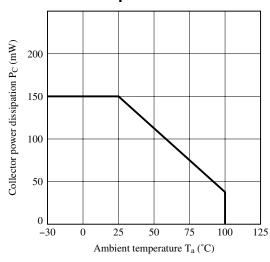


Fig.5 Total Power Dissipation vs. Ambient Temperature

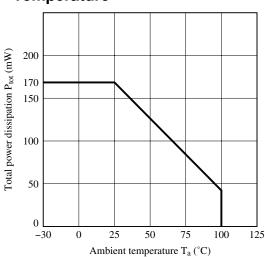




Fig.6 Peak Forward Current vs. Duty Ratio

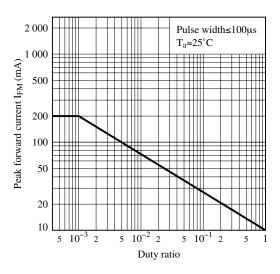


Fig.8 Current Transfer Ratio vs. Forward Current

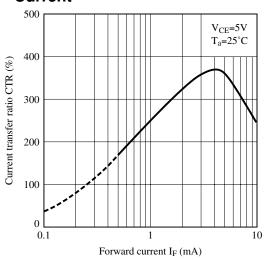


Fig.10 Relative Current Transfer Ratio vs.
Ambient Temperature

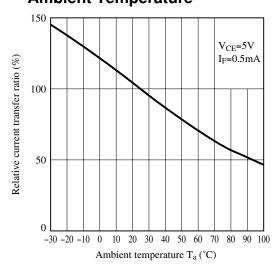


Fig.7 Forward Current vs. Forward Voltage

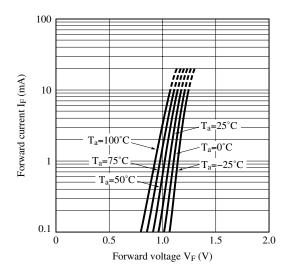


Fig.9 Collector Current vs. Collector-emitter Voltage

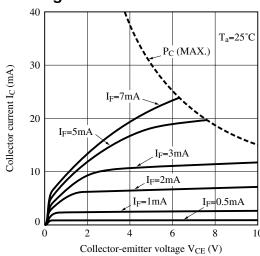


Fig.11 Collector - emitter Saturation Voltage vs. Ambient Temperature

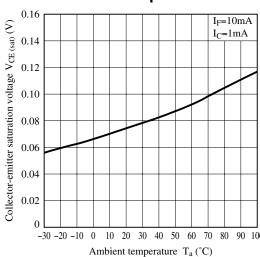




Fig.12 Collector Dark Current vs. Ambient Temperature

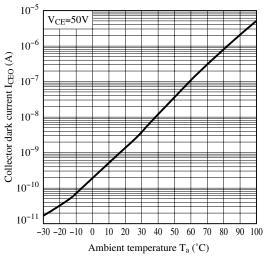
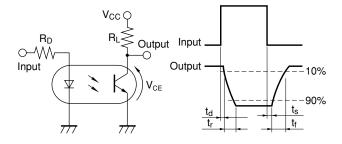


Fig.14 Test Circuit for Response Time



Please refer to the conditions in Fig.13.

Fig.16 Collector-emitter Saturation Voltage vs. Forward Current

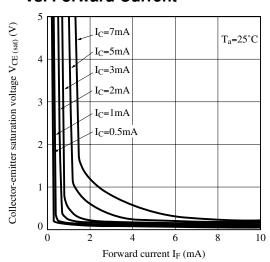


Fig.13 Response Time vs. Load Resistance

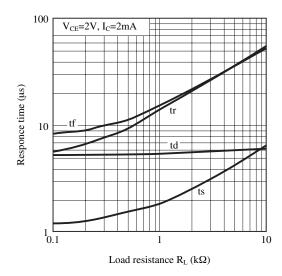
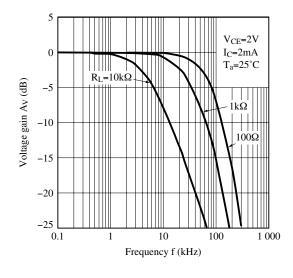


Fig.15 Frequency Response



Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



■ Design Considerations

Design guide

While operating at I_F<0.5mA, CTR variation may increase.

Please make design considering this fact.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through IRED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of IRED.

This product is not designed against irradiation and incorporates non-coherent IRED.

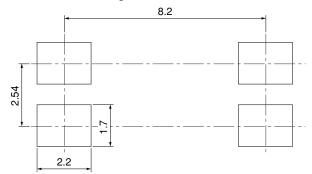
Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

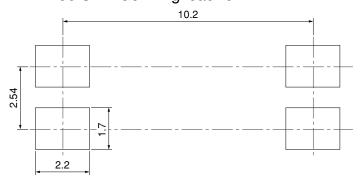
In the case of long term operation, please take the general IRED degradation (50% degradation over 5years) into the design consideration.

Recommended Foot Print (reference)

SMT Gullwing lead-form



Wide SMT Gullwing lead-form



(Unit: mm)

[☆] For additional design assistance, please review our corresponding Optoelectronic Application Notes.



■ Manufacturing Guidelines

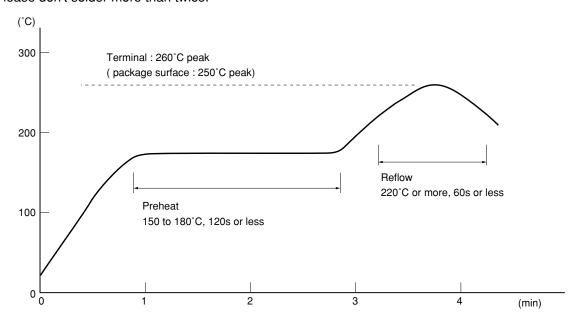
Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please don't solder more than twice.



Flow Soldering:

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



Cleaning instructions

Solvent cleaning:

Solvent temperature should be 45°C or below Immersion time should be 3minutes or less

Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this device.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

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■ Package specification

Sleeve package

1. Through-Hole

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

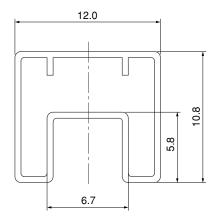
Package method

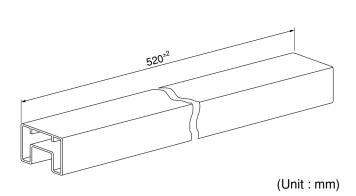
MAX. 100pcs of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions





2. Wide Through-Hole

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

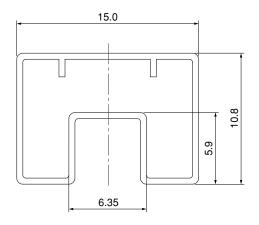
Package method

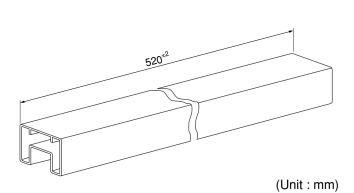
MAX. 100pcs of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions





Sheet No.: D2-A02902EN



● Tape and Reel package

1. SMT Gullwing

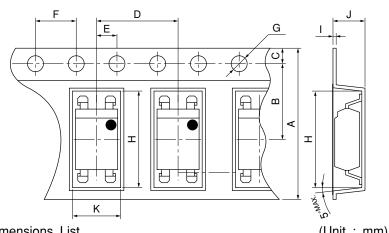
Package materials

Carrier tape : PS

Cover tape: PET (three layer system)

Reel: PS

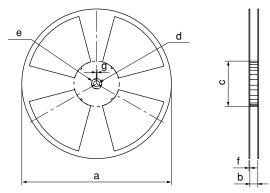
Carrier tape structure and Dimensions



Dimensions List

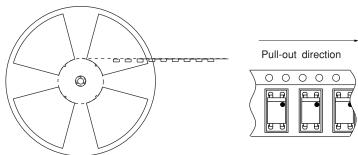
Difficusion	Differsions List (Office Film)								
A	В	C	D	Е	F	G			
16.0±0.3	$7.5^{\pm0.1}$	1.75 ^{±0.1}	8.0 ^{±0.1}	2.0 ^{±0.1}	4.0 ^{±0.1}	φ1.5 ^{+0.1}			
Н	I	J	K						
10.4 ^{±0.1}	$0.4^{\pm0.05}$	4.2 ^{±0.1}	5.1 ^{±0.1}						

Reel structure and Dimensions



Dimensio	ns List	(Unit: mm)		
a	b	с	d	
330	17.5 ^{±1.5}	100±1.0	13 ^{±0.5}	
e	f	g		
23±1.0	2.0 ^{±0.5}	2.0 ^{±0.5}		

Direction of product insertion



[Packing: 2 000pcs/reel]



2. Wide SMT Gullwing

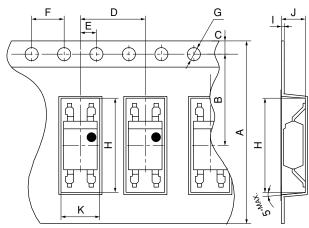
Package materials

Carrier tape: PS

Cover tape: PET (three layer system)

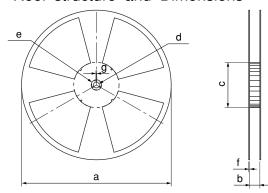
Reel: PS

Carrier tape structure and Dimensions



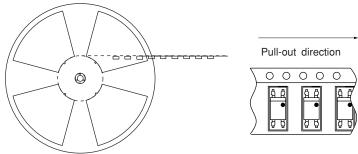
Dimensions List (Unit: mm) С A В D Е F G $4.0^{\pm0.1}$ 24.0±0.3 11.5^{±0.1} 1.75^{±0.1} $8.0^{\pm0.1}$ $2.0^{\pm0.1}$ φ1.5+0.1 Η K 12.4±0.1 $0.4^{\pm0.05}$ $4.1^{\pm0.1}$ 5.1^{±0.1}

Reel structure and Dimensions



Dimensio	ns List	(Unit: mm)		
a	b	c	d	
330	22.5±1.5	100±1.0	13±0.5	
e	f	g		
23 ^{±1.0}	2.0 ^{±0.5}	$2.0^{\pm0.5}$		

Direction of product insertion



[Packing: 2 000pcs/reel]



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 - --- Office automation equipment
 - --- Telecommunication equipment [terminal]
 - --- Test and measurement equipment
 - --- Industrial control
 - --- Audio visual equipment
 - --- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

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- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.
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 - --- Telecommunication equipment [trunk lines]
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